Solar PV Module Fault Analysis Using Artificial Intelligence

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ABSTRACT: This paper addresses the way for real time observance and fault analysis in electrical solar PV(photo voltaic) systems is projected. This approach is based on a comparison between the performances of a faulty electrical solar PV module, with its correct model by quantifying the precise differential residue which can be associated with it. The electrical signature of each default measure mounted by considering the deformations induced on the I-V curves and PV curves. All fault cases like module to module fault, short circuit fault, open circuit fault, cell-ground faults and totally different shading patterns measure are thought-about. The projected technique measure usually generalized and extended to further forms of faults. This faults condition was analyzed by comparisons of traditional condition solar PV and VI characteristics with faulty condition characteristics. The simulation results of MATLAB simulation model shows the results for various fault condition with variation of solar irradiation

KEYWORDS: Fault analysis, solar PV module, I-V curves and PV curves, module to module fault, cell-ground faults.

I. INTRODUCTION

A PV array sometimes has multiple parallel PV strings, and every string contains a variety of modules non parallel. each module, string, and whole array, whether or not in traditional or fault condition, has its own I-V characteristics .When PV modules are connected along, their total I-V curve is set by the interactions among them. For this reason, PV modules perform together like a chain that it is only as strong as the weakest link. Faults in PV arrays damage the PV modules and cables, as well as lead to electrical shock hazards and fire risk. In this paper all fault cases like module to module fault, short circuit fault, electric circuit fault, and cell-ground faults are thought-about. Module to module fault square are the foremost common variety of fault among PV arrays. Module to module fault in PV modules occur once the electrical parameters of one module considerably modified from those of the remaining modules. This could cause irreversible damage on PV modules and huge power loss. A line-line fault is typically outlined as a short-circuit fault among PV modules or array cables with completely different potential. A short-circuit faults don't involve any ground points. The most causes for a line-line fault could also be Incidental short between current carrying conductors, Insulation failure of cables. AN open-circuit fault is an accidental disconnection at a standard current-carrying conductor. This fault would possibly occur on cracking PV cells/modules, or between module interconnections, generally in bus wiring or junction box. Ground faults with PV modules, i.e. a photovoltaic cell short circuiting to grounded module frames because of deteriorating encapsulation of a PV module, impact damage, or water corrosion. The essential approaches of fault analysis include comparisons of traditional condition solar PV and VI characteristics with faulty condition characteristics and the simulation results of MATLAB simulation model shows the results for varied fault condition.

II. LITERATURE SURVEY

The effect of a parasitic resistance on the performance of PV modules was investigated in van Dyk and Meyer (2004), the variations in series and parallel resistances give a sign of possible aging of PV modules. Such degraded panels may cause a general mismatch fault on the whole PV array. Mismatching fault occurs when the electrical parameters of one module are different from that of the remaining modules in a given PV installation, this fault is the most common in PV systems and may cause irreversible damage (van Dyk et al., 2002). Partial shading is a particular case of the mismatch fault, it arises when a number of PV modules are subject to a different level of solar irradiation from the rest of the
installation, such temporary fault was studied extensively in the literature (Ahmed and Salam, 2015). Wiring-related faults are common in electric circuits, there are mainly two types of faults in PV-based installations: Line-to-Ground and Line-to-Line faults. In Bower and Wiles (2000), the line-ground fault was studied only on the AC side of the PV system, whereas the authors in Stellbogen (1993), Boutasseta et al. (2013) investigated its effect on the DC side. Line-to-line fault occurs when a short-circuit between the cables of two or more PV modules with different potential is detected (Zhao et al., 2013). To mitigate the effect of such issues, fault detection and identification (FDI) methods have been proposed to monitor the state of the PV system and warn the user of degradation signs of the PV array and any other unexpected change in the systems’ normal operation. Furthermore, FDI techniques allow the detection of wiring-related faults that may not be detected in some conditions using conventional over-current protection devices (Zhao et al., 2015). In Akram and Lotifard (2015), a review of fault diagnosis methods on the DC side of PV arrays is given, some of the methods take into account only detection of faults and some of them make both detection and classification. In this work we consider all types of faults presented but we take into account only fault detection, as fault classification will not have much impact on the fault tolerant control algorithm. Model-based approaches generally use an analytical model of the PV system to estimate the parameters, which will be compared to the measured ones obtained from real data. The generated residuals are used as fault features for diagnosis purposes. Recently, some model-based techniques rely on the PV power losses analysis. These modeling methods need knowledge of both irradiance and PV generator temperature to predict the output power of the PV system (Chouder and Silvestre, 2010; Kang et al., 2010). More recently, model-based techniques use the empirical parameters (fill factor (ff), short-circuit current (Isc), open-circuit voltage (Voc)...) that are calculated from the shape of the current-voltage (I-V) curves (Garoudjda et al., 2017; Ali et al., 2016; Spataru et al., 2015). The main advantage of these methods is that they have low hardware requirements and are applicable to a wide range of PV systems. If the designed model can capture the main physics of the system, these methods are efficient for shading detection. Data-driven approach is based on data history, collected during operation. Fault features are extracted and analysed for fault diagnosis.

III. PROPOSED METHODOLOGY AND DISCUSSION

Mismatching fault occurs when the electrical parameters of one module are different from that of the remaining modules in a given PV installation, this fault is the most common in PV systems and may cause irreversible damage. Partial shading is a particular case of the mismatch fault, it arises when a number of PV modules are subject to a different level of solar irradiation from the rest of the installation. Wiring-related faults are common in electric circuits, there are mainly two types of faults in PV-based installations: Line-to-Ground and Line-to-Line faults. Line-to-line fault occurs when a short-circuit between the cables of two or more PV modules with different potential is detected. To mitigate the effect of such issues, fault detection and identification (FDI) methods have been proposed to monitor the state of the PV system and warn the user of degradation signs of the PV array and any other unexpected change in the systems normal operation. Furthermore, FDI techniques allow the detection of wiring-related faults that may not be detected in some conditions using conventional over-current protection devices. In this work we consider all types of faults presented but we take into account only fault detection, as fault classification will not have much impact on the fault tolerant control algorithm.

On the other hand, the nonlinear nature of the Power-Voltage (P-V) characteristic curve of PV cells has made the control procedure more difficult. Many maximum power point tracking (MPPT) algorithms were developed to extract maximum power from PV panels by searching the nonlinear curve for the optimal operating point. The first algorithm that has been proposed is the Perturb & observe (P&O) algorithm, this algorithm searches the P-V curve for the maximum power point (MPP) by perturbing the actual operating point of the PV system and analyzing its effect on the output power until it reaches the optimal operating point. Such periodic change in the reference value generates oscillations around the maximum power point. The amplitude of the oscillations can be reduced by choosing a variable step perturbation. The proposed methods deal with the problem of sudden change in solar irradiation and some of them manage to control the PV module in the case of partial shading. In the PSO-based MPPT algorithm proposed to control PV arrays under partial shading, the voltage variable is used as a particle in the particle swarm optimization procedure; such approach slows the convergence of the algorithm because of the large space of search that extends to the open circuit voltage. The duty cycle is chosen to track the global MPP by eliminating the need for a regulator in the PSO-based MPPT algorithm. Fault tolerance in PV panels was propose as a reconfiguration mechanism for the PV cells in other to bypass faulted ones. However, the used techniques often require a relatively high cost in equipment or
complexity in the diagnosis process development. In general, they are three main approaches used for PV fault diagnosis: image-based, model-based and process history-based also known as data-driven. The common image-based PV diagnosis methods are the ElectroLuminescence (EL) and the IRT imaging under steady state conditions. These methods are becoming increasingly popular, since they offer efficient solution not only for detecting the fault occurrence within a PV plant, but also for isolating accurately the fault. Such optical inspection techniques need appropriate and expensive equipment. EL-based diagnosis method is rather efficient to indicating the existence and the location of contact failures; cell cracks and shunts, inactive PV cells or sub- and potential induced degradation (PID) with high accuracy.

IRT-based method is fast, real time and effective to detect and exactly locate the faults thanks to the thermal signature, and without disturbing or interrupting the PV system operation. However, IRT method needs also specific conditions to be performed for correct and accurate temperature measurement. Model-based approaches generally use an analytical model of the PV system to estimate the parameters, which will be compared to the measured ones obtained from real data. The generated residuals are used as fault features for diagnosis purposes. Recently, some model based techniques rely on the PV power losses analysis these modeling methods need knowledge of both irradiance and PV generator temperature to predict the output power of the PV system. More recently, model-based techniques use the empirical parameters that are calculated from the shape of the current-voltage (I-V) curves. The main advantage of these methods is that they have low hardware requirements and are applicable to a wide range of PV systems. If the designed model can capture the main physics of the system, these methods are efficient for shading detection. Data-driven approach is based on data history, collected during operation. Fault features are extracted and analysed for fault diagnosis. Among signal processing techniques, time-domain reflectometry (TDR) is used to detect and identify open-circuit faults and spread spectrum time-domain reflectometry (SSTDR) techniques are used to detect catastrophic faults, ground-faults and PV arc fault.

BLOCK DIAGRAM

These techniques are costly and require a specific external signal function generator. Moreover, they are not used to detect and identify shading faults. Other techniques extract the fault features from the I-V characteristic of PV module, string or array. Based on the analysis of the first and the second derivatives of I-V curves detect the activation of bypass diodes that indicate the presence of shading fault. This fault is also detected by comparing the I-V curves in normal and shaded operations. These methods are simple and effective to detect shading faults.
This is the reason why backpropagation requires the activation function to be non-linear and differentiable. A commonly used activation function is the logistic function:

$$\varphi(z) = \frac{1}{1 + e^{-z}}$$

which has a nice derivative of:

$$\frac{\partial \varphi}{\partial z} = \varphi(1 - \varphi)$$

1) Finding the derivative of the error

Calculating the partial derivative of the error with respect to a weight $w_{ij}$ is done using the chain rule twice:

$$\frac{\partial E}{\partial w_{ij}} = \frac{\partial E}{\partial o_j} \cdot \frac{\partial o_j}{\partial \text{net}_j} \cdot \frac{\partial \text{net}_j}{\partial w_{ij}}$$

In the last term of the right-hand side, only one term in the sum $\text{net}_j$ depends on $w_{ij}$, so that

$$\frac{\partial \text{net}_j}{\partial w_{ij}} = \frac{\partial}{\partial w_{ij}} \left( \sum_{k=1}^{r} w_{kj} x_k \right) = x_k$$

The derivative of the output of neuron $j$ with respect to its input is simply the partial derivative of the activation function (assuming here that the logistic function is used):

$$\frac{\partial o_j}{\partial \text{net}_j} = \varphi'(\text{net}_j) = \varphi(\text{net}_j)(1 - \varphi(\text{net}_j))$$

This is the reason why backpropagation requires the activation function to be differentiable

The first term is straightforward to evaluate if the neuron is in the output layer, because then $o_j = y$ and

$$\frac{\partial E}{\partial o_j} = \frac{\partial E}{\partial y} = \frac{\partial}{\partial y} \frac{1}{2}(t - y)^2 = y - t$$
However, if \( \hat{J} \) is in an arbitrary inner layer of the network, finding the derivative \( \frac{\partial E}{\partial J} \) with respect to \( \partial J \) is less obvious.

Considering \( \frac{\partial E}{\partial J} \) as a function of the inputs of all neurons \( L = u_1, u_2, \ldots, u \) receiving input from neuron \( J \),

\[
\frac{\partial E}{\partial J} = \frac{\partial E}{\partial \text{net}_j} \frac{\partial \text{net}_j}{\partial J}
\]

and taking the total derivative with respect to \( \partial J \), a recursive expression for the derivative is obtained:

\[
\frac{\partial E}{\partial J} = \sum_{t \in L} \left( \frac{\partial E}{\partial \text{net}_t} \frac{\partial \text{net}_t}{\partial J} \right) = \sum_{t \in L} \left( \frac{\partial E}{\partial \text{net}_t} \frac{\partial \text{net}_t}{\partial \text{net}_j} \frac{\partial \text{net}_j}{\partial J} \right)
\]

Therefore, the derivative with respect to \( \partial J \) can be calculated if all the derivatives with respect to the outputs \( \partial L \) of the next layer – the one closer to the output neuron – are known. Putting it all together:

\[
\frac{\partial E}{\partial \text{net}_j} = \delta x_j
\]

with

\[
\delta_j = \frac{\partial E}{\partial \text{net}_j} = \begin{cases} (a_j - t_j) \psi(\text{net}_j)(1 - \psi(\text{net}_j)) & \text{if } j \text{ is an output neuron,} \\ (\sum_{i \in L} w_{ij} \psi(\text{net}_i)(1 - \psi(\text{net}_i))) & \text{if } j \text{ is an inner neuron.} \end{cases}
\]

To update the weight \( w_{ij} \) using gradient descent, one must choose a learning rate. The change in weight, which is added to the old weight, is equal to the product of the learning rate and the gradient, multiplied by -1:

\[
\Delta w_{ij} = -\alpha \frac{\partial E}{\partial w_{ij}}
\]

The -1 is required in order to update in the direction of a minimum, not a maximum, of the error function.

V. RESULT

<table>
<thead>
<tr>
<th>Name of fault</th>
<th>Fault case</th>
<th>Module ground to</th>
<th>Module to module</th>
<th>Open circuit fault</th>
<th>Shading effect</th>
<th>Mismatch fault</th>
</tr>
</thead>
<tbody>
<tr>
<td>Module to ground</td>
<td>1</td>
<td>1</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>Module to module</td>
<td>2</td>
<td>0</td>
<td>1</td>
<td>0</td>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>Open circuit</td>
<td>3</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>Shading effect</td>
<td>4</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>0</td>
</tr>
<tr>
<td>Mismatch fault</td>
<td>5</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
</tr>
</tbody>
</table>

Table 1: Target output of ANN for solar PV module fault classification

Neural network training for solar pv system different fault classification was presented. For that separate neural network structure are utilized for classification and input for neural network was three parameters that is solar pv voltage, current and output power. The solar pv module output parameters like output voltage, output current and output power was measured at different fault conditions and that parameters was utilized for training data set for neural network training.

Neural network train for 5 types of fault conditions like module to ground, module to module, open circuit fault, and shading effect and mismatch faults. These faults conditions were simulated in matlab simulink model.

![Figure ii: MATLAB simulink window for selection of training, validation and testing data set](image-url)
Figure ii shows the selection of percentage of training data set, validation data set and testing data set from entire 844 numbers of training samples.

**Training data set:** These are presented to the network during training, and the network is adjusted according to its error.

**Validation data set:** These are used to measure network generalization, and to halt training when generalization stops improving.

**Testing data set:** These have no effect on training and so provide an independent measure of network performance during and after training.

Hidden layer is consist of 10 neurons and having sigmoidal activation function of each neuron while output neuron is consist of 5 neurons and having soft competitive activation function.

Figure iv shows the training performance window for training of pv solar system fault classification neural network. In this total 54 epochs are required for complete training of ANN using back propagation algorithm. Gradient for this training was measures as $1 \times 10^{-6}$. 

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Figure v shows, For training of ANN, total 488 data sample was utilized out of which 590 data set i.e. 70% data utilized for training. For validation and testing 30% dataset was utilize i.e. 127 sample data set. Also MSE (Mean square error) for all data set was 27.288 % after successful training of ANN.

The receiver operating characteristic is a metric used to check the quality of classifiers. For each class of a classifier, roc applies threshold values across the interval [0,1] to outputs. For each threshold, two values are calculated, the True Positive Ratio (the number of outputs greater or equal to the threshold, divided by the number of one targets), and the False Positive Ratio (the number of outputs less than the threshold, divided by the number of zero targets).
VI. CONCLUSION

Through this paper, MATLAB simulation model of solar PV array system was proposed which used to simulate different fault conditions in solar PV array system using MATLAB 2015 software. In these proposed approach different condition are simulated in which it is cleared that when open circuit fault occurs then output current and output voltage decreases very rapidly as compared with module to module and module to ground fault. Back-propogation algorithm based Neural network as artificial intelligence (AI) was utilized for classification of different solar pv fault classification. The simulation model is able to take the solar irradiance level and PV module temperature as inputs, and predict accurate steady-state performance compared with the manufacturer’s datasheet. Furthermore, the model is flexible enough to simulate solar PV arrays with different scales, with or without bypass diodes and diverse technologies. Hence this PV simulation model is modular and scalable to build PV arrays with various configurations, which is especially useful for studies of PV modules interconnection under normal and fault scenarios.

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